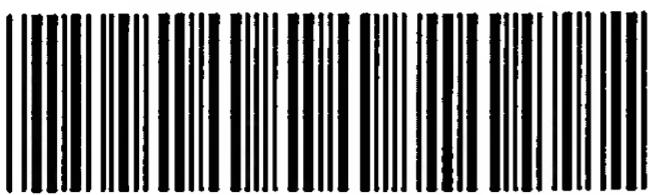


Search Notes



Application/Control No.

10/606 768

Examiner

Chuc D. Tran

**Applicant(s)/Patent under
Reexamination**

HA ET AL.

Art Unit

2821

SEARCHED

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
315	169.3	4/12/2006	TC
345	76,82	4/12/2006	TC
Interference Search History		4/12/2006	TC

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**